EFFECTS IN OPTICAL PATTERNATION OF CORRECTING FOR ATTENUATION SPRAYS

V.G. MCDONELL, ERC & D.G. TALLEY, AFRL **DEMONSTRATION OF CORRECTION** METHODOLOGY DEVELOPED BY

AIR FORCE CONTRACT F04611-97-C-0084

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MOTIVATION

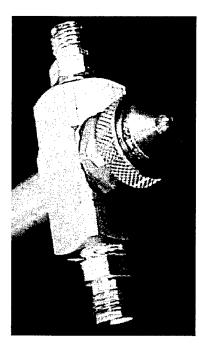
- "OPTICAL PATTERNATION" OF SPRAYS
- PLANAR LASER INDUCED FLUORESCENCE APPROACH
- DISTRIBUTION OF MASS THROUGHOUT SPRAY
- NON-INTRUSIVE
- RAPID
- GAINING ACCEPTANCE AS SPRAY DIAGNOSTIC
- BARRIERS TO QUANTITATIVE RESULTS
- CAMERA RESPONSE ISSUES
- ATTENUATION OF EXCITING LIGHT
- ATTENUATION OF SIGNAL LIGHT

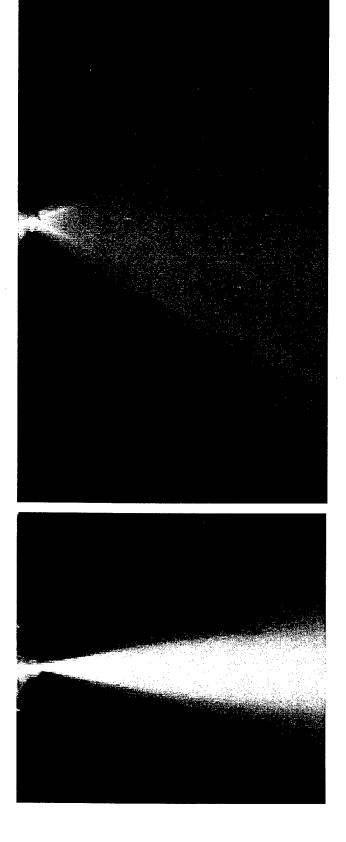
ADDRESSING BARRIERS

- SIMULTANEOUSLY ACCOUNT FOR ATTENUATION OF NOVEL METHODOLOGY HAS BEEN DEVELOPED TO
- EXCITATION LIGHT
- SIGNAL LIGHT

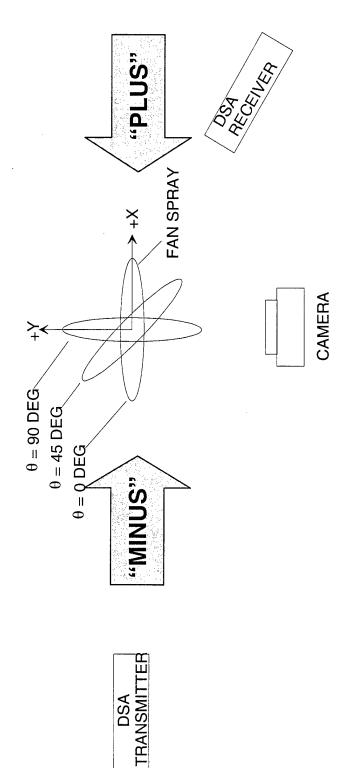
TWIN-FLUID FAN SPRAY:

- CONTROLLED ATTENUATION EFFECTS
- SYMMETRIC ELLIPTIC DISTRIBUTION





TOP VIEW ORIENTATION



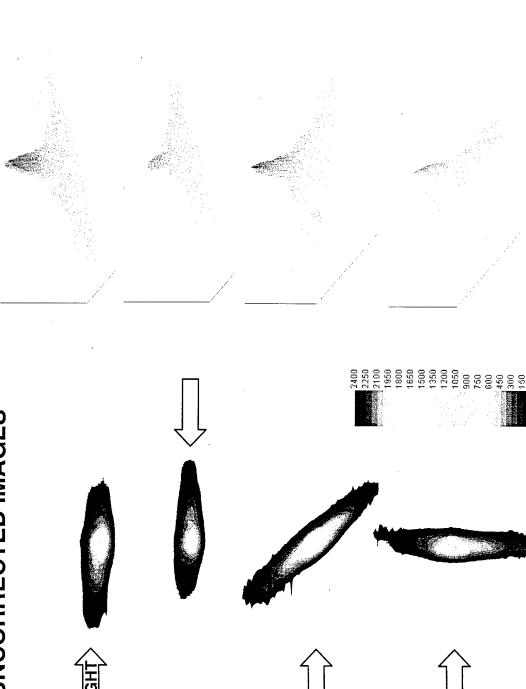
ATTRIBUTES:

0-DEG: MAXIMUM INCIDENT LIGHT ATTENUATION

90-DEG: MAXIMUM SIGNAL ATTENUATION

45-DEG: MINIMUM INCIDENT LIGHT OR SIGNAL ATTENUATION

UNCORRECTED IMAGES



45 DEG

O DEG REV.

O DEG

90 DEG

 IMPORTANCE OF CORRECTION: UPPER AND LOWER **IMAGES SHOULD BE IDENTICAL BUT ROTATED**

UNCORRECTED

PRESENT FULL CORRECTION

CORRECTION FOR INCIDENT LIGHT ONLY







0 DEG







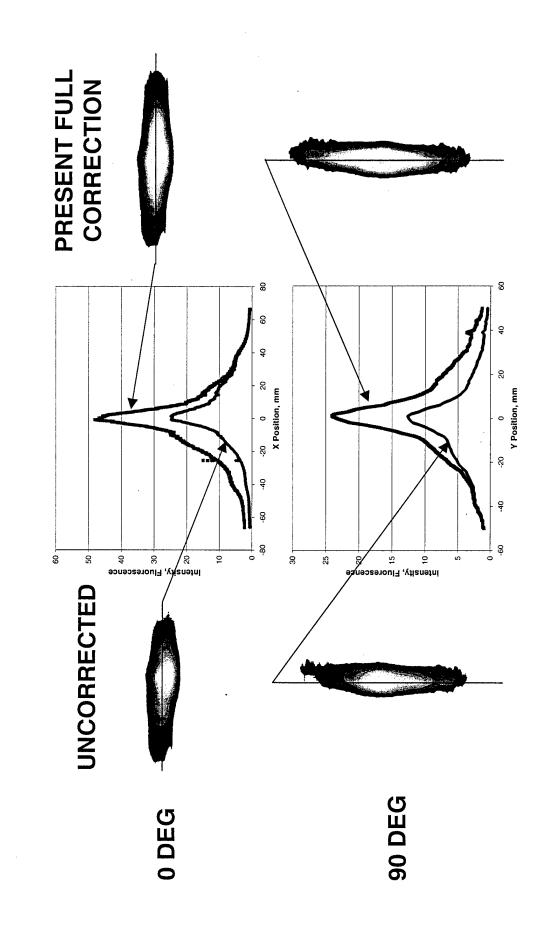




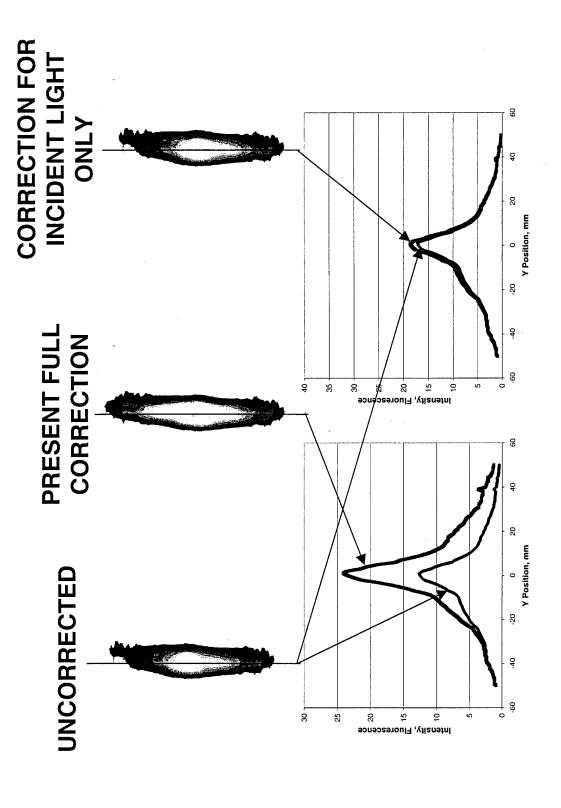
90 DEG



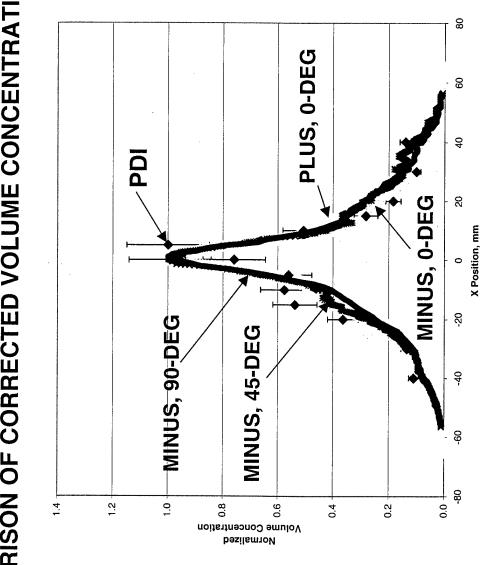
IMPORTANCE OF CORRECTION: LINE PROFILES



• IMPORTANCE OF CORRECTION FOR SIGNAL: 90 DEG ORIENTATION



COMPARISON OF CORRECTED VOLUME CONCENTRATION TO PDI



CONCLUSIONS

- CORRECTION REQUIRED FOR ACCURATE RESULTS IN SPRAYS WITH SIGNIFICANT OPTICAL THICKNESS
- INCIDENT LIGHT
- SIGNAL LIGHT
- METHODOLOGY HAS BEEN DEVELOPED TO ACCOUNT FOR ATTENUATION OF BOTH INCIDENT AND SIGNAL LIGHT
- DEMONSTRATIONS TO DATE HAVE REVEALED GOOD **PERFORMANCE**
- 63% "OBSCURATION"

MEMORANDUM FOR PR (Contractor/In-House Publication)

FROM: PROI (TI) (STINFO)

23 Jun 2000

SUBJECT: Authorization for Release of Technical Information, Control Number: AFRL-PR-ED-TP-2000-140 V. McDonel (ERC); D. Talley (AFRL/PRSA), "Correcting for Attenuation Effects in Optical Patternation of Sprays"

10th International Symposium on Applications of Laser Techniques to Fluid (Statement A) Mechanics (Lisbon, Portugal, 10-13 Jul 00)

8th International Conference on Liquid Atomization and Spray Systems

(Pasadena, CA, 16-20 June 00)

(Submission Deadline: 19 Jun 00)

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	LESLIE S. PERKINS, Ph.D (Date) Staff Scientist

Propulsion Directorate

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